

Search Notes

Application/Control No.

10/621,572

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	241-245, 256-261	5/31/2005	HP
359	212	5/31/2005	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/31/2005	HP